Form PTO 1449 U.S. DEPARTMENT OF COMMERCE (Modified) PATENT AND TRADEMARK OFFICE			OF COMMERCE DEMARK OFFICE	ATTY DOCKET NO.		SERIAL NO.	
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LIST OF	REFE	RENCES CITED BY AP	PLICANT	APPLICANT			
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	AE						
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	AH			*			
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		DOCUMENT NUMBER	DATE	COUNTRY		TRANSLATION YES NO	
	AO	11-330468	11/30/1999	Japan with English Abstract (corresponding to EP 0 964 437 A2 and U.S. 2007/0184618)			×
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OTHER REFERENCES (Including Author, Title, Date, Pertinent Pages, etc.)							
	AW						
	AX						
	AY						
	AZ				Addit	ional Refe	rences sheet(s) attached
Examiner		*			Date Considered		
*Examiner: Initial if reference is considered, whether or not citation is in conformance with MPEP 609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.							
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